

L Number	Hits	Search Text	DB	Time stamp
1	18569	semiconductor and drift	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/05/15 14:56
2	156	(semiconductor and drift) and (source adj side) and (drain adj side)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/05/15 14:57
3	153	((semiconductor and drift) and (source adj side) and (drain adj side)) and gate	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/05/15 15:21